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| Search Notes  | Application No. | Applicant(s) | |
| | 09/785,044 | ILIFF, EDWIN C. | |
| | Examiner | Art Unit | |
| | Joon H. Hwang | 2162 | |

| SEARCHED | | | |
|----------|-----------|----------|--------------------|
| Class | Subclass | Date | Examiner |
| 707 | 1-10 | 4/1/2005 | <i>[Signature]</i> |
| 707 | 100-104.1 | 4/1/2005 | <i>[Signature]</i> |
| 600 | 300 | 4/1/2005 | <i>[Signature]</i> |
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| INTERFERENCE SEARCHED | | | |
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| Class | Subclass | Date | Examiner |
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| SEARCH NOTES (INCLUDING SEARCH STRATEGY) | | |
|--|----------|--------------------|
| | DATE | EXMR |
| Palm EAST & WEST (USPAT, US-PGPUB, JPO, EPO, DERWENT, IBM TDB) ACM IEEE | 4/1/2005 | <i>[Signature]</i> |
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